

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/760,779	CHANG ET AL.
	Examiner Curtis B. Odom	Art Unit 2634

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Fast USPAT; USPTOUS; EPO; JPO; DERWENT (see text printout)	9/29/05	C2D
375/130-153 - see text printout	9/29/05	C2D
Inventorship	9/29/05	C2D

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner